# The new radiation-hard optical links for the ATLAS pixel detector



K.K. Gan, H.P. Kagan, R.D. Kass, J. Moss, J. Moore, S. Smith, Y. Yang The Ohio State University

> P. Buchholz, M. Ziolkowski Universität Siegen

#### OUTLINE

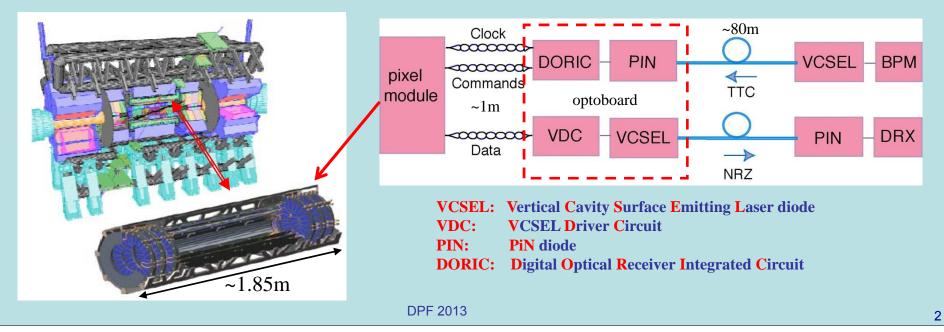
Lessons learned... IBL/nSQP opto-board overview assembly experience radiation hardness production Summary/Conclusions



### Pixel Optical Data Links



Öptical data transmission preferred over copper wire links: optical fibers are lower in mass than copper higher data transmission rate over long distances (80m) no ground loop between front and back end electronics Optical Transmitter: VCSEL (vertical cavity surface-emitting laser) Optical Receiver: PIN diode Can be packaged in one, four, twelve channels Work in the radiation environment of the LHC



#### The pre-IBL Opto-board



44 B boards

228 D boards

Optical signal  $\Leftrightarrow$  electrical signal conversion occurs here

#### Contains 7 optical links, each link serving one Pixel module Fabricated in 2 flavors

- Layer B: for inner barrel, 2 data links per module for high occupancy
- Layer D: for outer barrel and disks 1 and 2

Fabricated with **BeO** for heat management

 VCSEL array
 Opto-pack

 VDC
 Pin array

 VDC
 DORIC

 Rkss
 DF203

# Pixel Opto-board Lessons 2010-12



On opto-boards, only 1 confirmed VCSEL death (connected but not lasing) We were saved by the low humidity environment There are some weak links (besides the VCSELs) we have addressed on the new opto-boards Single Iset line (pin) per board ©Added a redundant pin to the 80/100 pin connector (nSQP/IBL) Soldering of opto-packs ©Suspect 15 VCSEL and 6 PIN failures due to cold solder joints ©New Opto-pack connections are wire bonded DORIC reset daisy chain Some DORIC channels/modules hard to configure have a broken reset line ©Added an redundant pin on the 80 pin connector ©Improved routing so no more daisy chaining through chips

### IBL/nSQP Opto-board Overview



- Use same 0.25 µm DORIC /VDC ASIC chips as present pixel opto-boards
- Use copper+Polyimide instead of BeO for the PCB
- Switch to industry standard MTP fiber connector and OSU opto-pack
- Switch to fully qualified Finisar VCSEL and ULM PIN arrays Finisar V850-2093-001 ULMPIN-04-TN-U0112U

nSQP: 2 flavors of opto-boards (for legacy fiber mapping)

- B-Layer
- D-Tall
- All equipped with 14 DTO / 7 TTC (enables operation at higher rates)
- IBL: 1 flavor of opto-board
  - 16 DTO / 8 TTC

DTO: data output signal TTC: timing, trigger, control signal

# nSQP/IBL Opto-Board Prototyping



We have constructed 10 nSQP B-boards

> 5 for irradiation 5 for system tests (2 to CERN 1 to SLAC, 1 to BERN, 1 to Wuppertal) 6 nSQP D-boards All for system tests (4 to CERN) 2 failed QA 1 with bad wire-bonds

> > 1 with a bad DORIC (slipped through test in 2005)

6 IBL boards

All for system tests (5 to CERN, 1 to SLAC)

No complaints received on distributed boards

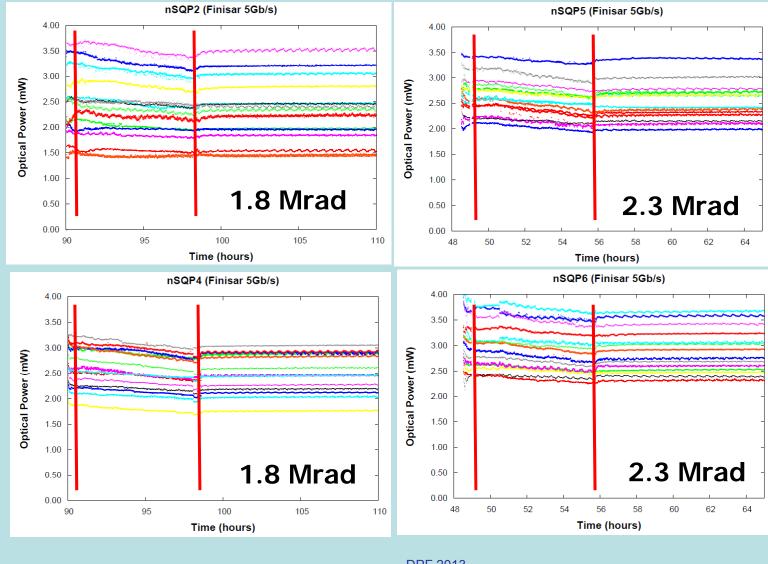
### Opto-board Radiation Hardness



0.25 µm DORIC and VDC ASICs well exercised Dedicated ASIC irradiation to 61 Mrad (2003) 4 production opto-boards to 30 Mrad (2004) 10 opto-boards to 30 Mrad for VCSEL/PIN SEU R&D (2006-9) VCSEL/PIN gualified **Opto-boards** exercised Constructed 6 nSQP B-Layer boards in July 2011 Used Finisar 5Gb/s VCSELs and ULM PINs on OSU Opto-packs Irradiated 2 sets of 2 boards with 24 GeV protons @ CERN First set  $8 \times 10^{13} \text{ p/cm}^2 \rightarrow 1.8 \text{ Mrad}$  (18 KGy) Second set  $10.4 \times 10^{13} \text{ p/cm}^2 \rightarrow 2.3 \text{ Mrad}$  (23 KGy) Test successful: No failed channels , PIN current thresholds for no bit errors remained constant, modest decrease in output optical power, boards fully functional after irradiation Since IBL board of identical construction, no need to repeat



#### nSQP B-Layer Irradiation Modest degradation in VCSEL output power



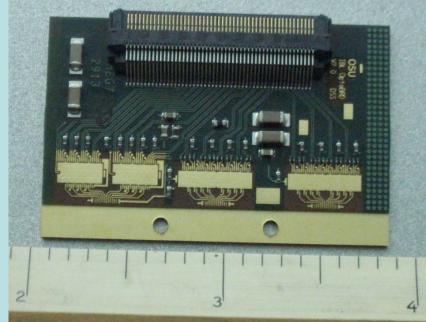


### IBL/nSQP Opto-boards

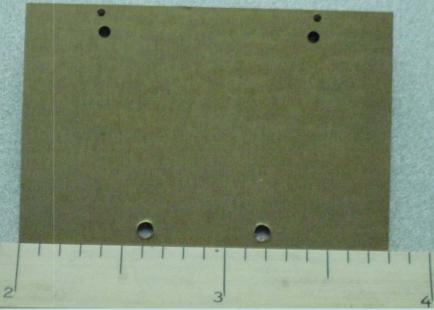
#### Mounting of passive components (outside vendor) Electrical open/short test 30 mm x 46 mm PCB

6-layer board

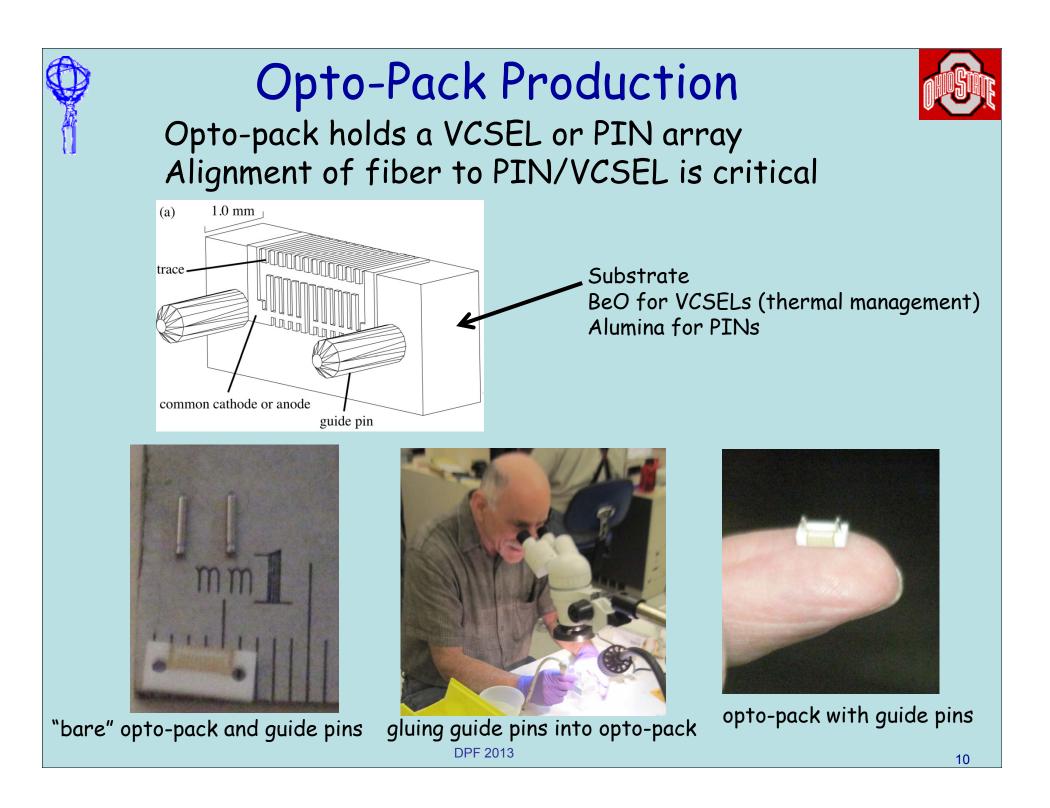
Use copper for thermal management



Component side passive components mounted by vender Everything else mounted at Ohio State



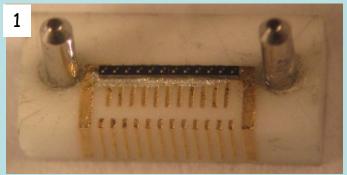
Backside 1mm thick copper backing plate slides into cooling rail



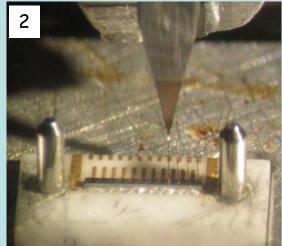
#### **Opto-Pack Production**



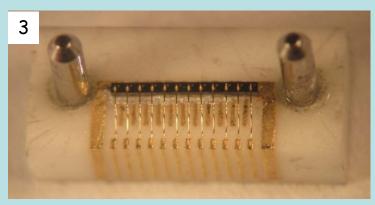
Produce opto-packs (2 VCSEL, 1 PIN per opto-board) PIN/VCSEL array must be put on Opto-pack & connected to traces VCSEL QA: LIV, reverse bias looking for ESD PIN QA: dark current, illuminate with 1mW & measure responsivity, check specs



PIN/VCSEL array glued to opto-pack



wire bonding to PIN/VCSEL



#### wire bonded PIN/VCSEL array



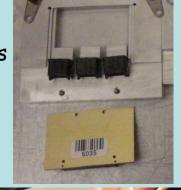
dust cover installed

DPF 2013

#### Opto-board Production Procedure



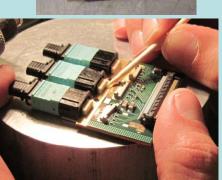
Mounting of optical connectors





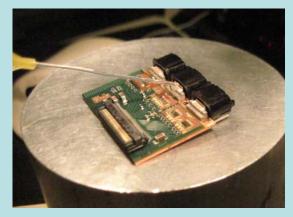
Wire bonding chips to board, board to opto-packs

Mounting of opto-packs









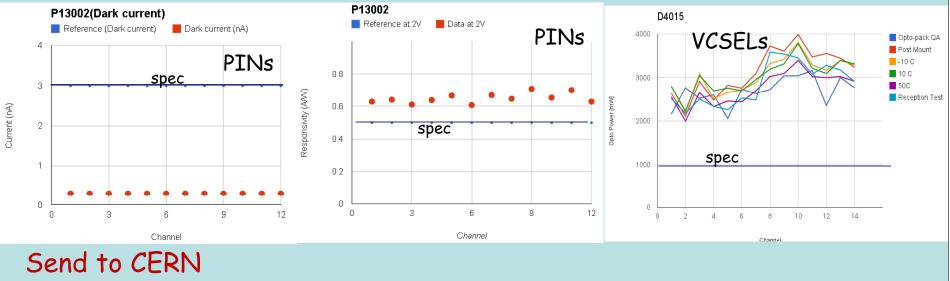
Encapsulation of wire bonds

DPF 2013

#### Opto-board Q/A Procedure

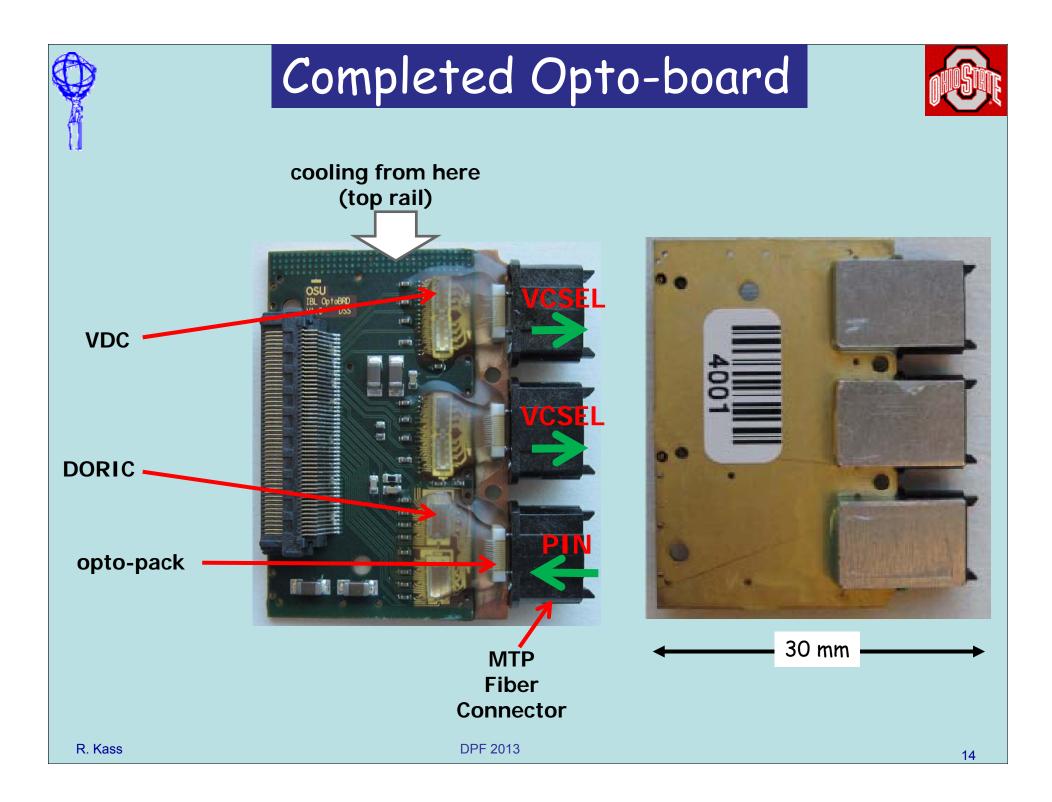


Go/No Go Test check optical power, all channels error free Burn in: 72hrs @ 50° C, powered Thermal cycling: 0° C -> + 50° C, 10 cycles, 2hrs per cycle Full electrical and optical QA at 10° C error free for 1 hr at 10° C (data at 40 Mbits) measure optical power at 0, 10, 10, 50° C check LVDS, jitter, rise/fall time, duty cycle



Send to CERN Reception Test at CERN Go/No Go Test Install R. Kass

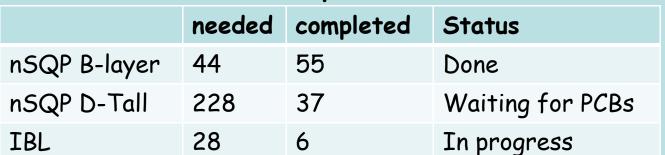
DPF 2013

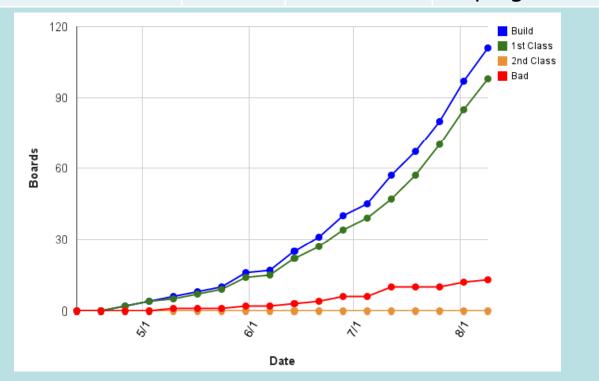


# IBL/nSQP Opto-board Summary



#### We have been in production for ~ 3 months



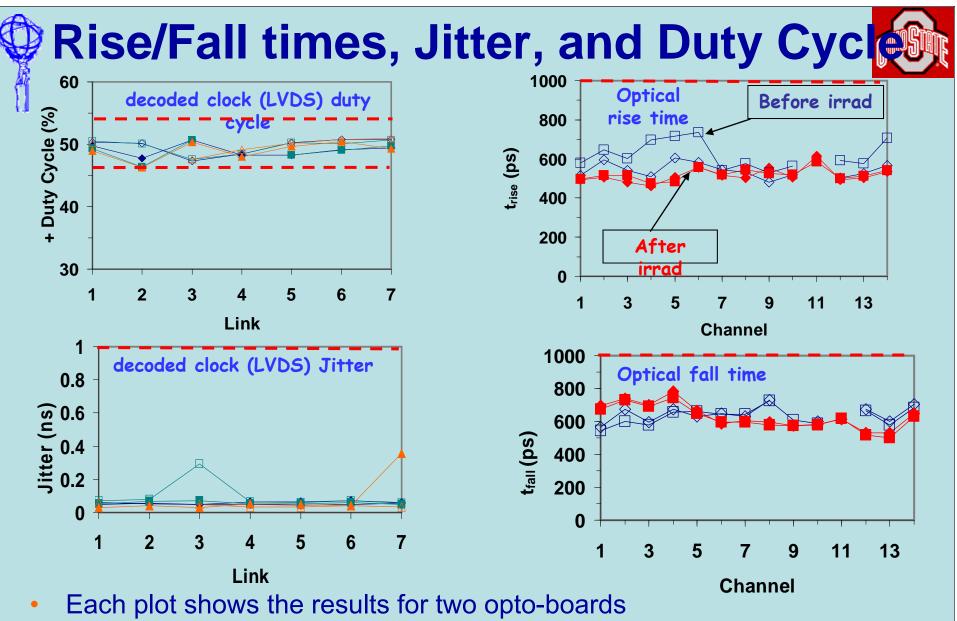


#### Expect to finish production late fall.









- No degradation in rise/fall times
- Decoded clock duty cycle and jitter within the limits after irradiation

### Opto-board Reception Tests at CERN



- Delivered and setup a copy of the QA system from OSU at CERN
- Reception test
  - Optical power must be consistent with OSU QA
  - Check that delivered boards operate with no bit errors at PIN current of 100  $\mu A$  1 mA
- System test
  - All boards should be tested within a replica of the full readout chain after passing the reception

